


<b>Search Notes</b>  	<b>Application/Control No.</b>  10595201	<b>Applicant(s)/Patent Under Reexamination</b>  NISHIO ET AL.
	<b>Examiner</b>  LAURA M LEE	<b>Art Unit</b>  3724

SEARCHED			
Class	Subclass	Date	Examiner
83	879, 884-887,	10/26/2009	LML
225	2, 93.5, 94, 96, 96.5,	10/26/2009	LML
33	18.1, 27.031	10/26/2009	LML

SEARCH NOTES		
Search Notes	Date	Examiner
East search, text search, inventor name search, considered IDS	10/26/2009	LML

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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